Memory FRAM

1 M Bit (64 K × 16)

MB85R1002A

■ DESCRIPTIONS

The MB85R1002A is an FRAM (Ferroelectric Random Access Memory) chip consisting of 65,536 words \times 16 bits of nonvolatile memory cells fabricated using ferroelectric process and silicon gate CMOS process technologies.

The MB85R1002A is able to retain data without using a back-up battery, as is needed for SRAM. The memory cells used in the MB85R1002A can be used for 10¹⁰ read/write operations, which is a significant improvement over the number of read and write operations supported by Flash memory and E²PROM. The MB85R1002A uses a pseudo-SRAM interface that is compatible with conventional asynchronous SRAM.

■ FEATURES

• Bit configuration : 65,536 words × 16 bits

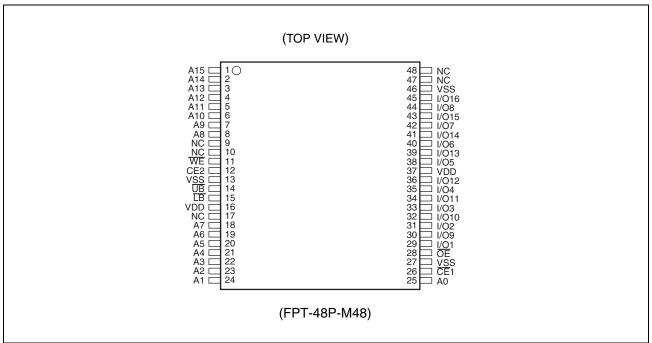
Read/write endurance : 10¹⁰ times
 Operating power supply voltage : 3.0 V to 3.6 V
 Operating temperature range : -40 °C to +85 °C
 Data retention : 10 years (+55 °C)

• LB and UB data byte control

• Package : 48-pin plastic TSOP (1)



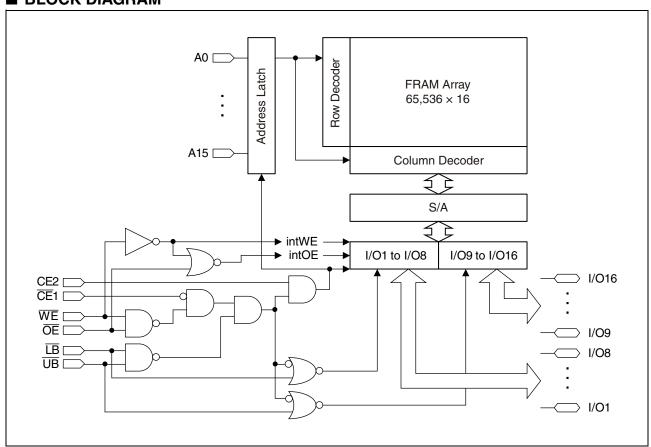
■ PIN ASSIGNMENTS



■ PIN DESCRIPTIONS

Pin Number	Pin Name	Functional Description
1 to 8, 18 to 25	A0 to A15	Address Input pins
29 to 36, 38 to 45	I/O1 to I/O16	Data Input/Output pins
26	CE1	Chip Enable 1 Input pin
12	CE2	Chip Enable 2 Input pin
11	WE	Write Enable Input pin
28	ŌĒ	Output Enable Input pin
14, 15	ĪB, ŪB	Data Byte Control Input pins
16, 37	VDD	Supply Voltage pins Connect all two pins to the power supply.
13, 27, 46	VSS	Ground pins Connect all three pins to ground.
9, 10, 17, 47, 48	NC	No Connect pins

■ BLOCK DIAGRAM



■ FUNCTIONAL TRUTH TABLE

Mode	CE1	CE2	WE	ŌĒ	LB	ŪB	I/O1 to I/O8	I/O9 to I/O16	Supply Current								
	Н	Χ	Χ	Χ	Χ	Χ											
Standby Precharge	Χ	L	Χ	Χ	Χ	Χ	Hi-Z	Hi-Z	Standby								
Otanaby i recharge	Х	Х	Η	Η	Χ	Χ	1112	1112	(IsB)								
	X	Х	X	Χ	Н	Н											
					L	L	Data Output	Data Output									
	Ł	Н	Н	L	L	Н	Data Output	Hi-Z									
Read					Н	L	Hi-Z	Data Output									
Neau					L	L	Data Output	Data Output									
	L	\perp	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	L	Н	Data Output	Hi-Z	i
					Н	L	Hi-Z	Data Output									
Read					L	L	Data Output	Data Output									
(Pseudo-SRAM,	L	Н	Н	Ł	Ł	Ł	L	Н	Data Output	Hi-Z							
OE control*¹)					Н	L	Hi-Z	Data Output	Operation								
					L	L	Data Input	Data Input	(Icc)								
	Ł	Н	L	Н	L	Н	Data Input	Hi-Z									
Write					Н	L	Hi-Z	Data Input									
vviile					L	L	Data Input	Data Input									
	L	工	L	Н	L	Н	Data Input	Hi-Z									
					Н	L	Hi-Z	Data Input									
Write					L	L	Data Input	Data Input									
(Pseudo-SRAM,	L	Н	Ł	Н	L	Н	Data Input	Hi-Z									
WE control*2)					Н	L	Hi-Z	Data Input									

Note: $L = V_{IL}$, $H = V_{IH}$, X can be either V_{IL} or V_{IH} , Hi-Z = High Impedance

 $[\]searrow$: Latch address and latch data at falling edge, \searrow : Latch address and latch data at rising edge

^{*1 :} $\overline{\text{OE}}$ control of the Pseudo-SRAM means the valid address at the falling edge of $\overline{\text{OE}}$ to read.

^{*2 :} $\overline{\text{WE}}$ control of the Pseudo-SRAM means the valid address and data at the falling edge of $\overline{\text{WE}}$ to write.

■ ABSOLUTE MAXIMUM RATINGS

Parameter	Cumbal	Rat	Unit	
Parameter	Symbol	Min	Max	Ollit
Power Supply Voltage*	Vcc	-0.5	+4.0	V
Input Pin Voltage*	Vin	-0.5	$V_{CC} + 0.5 \ (\le 4.0)$	V
Output Pin Voltage*	Vout	-0.5	$V_{CC} + 0.5 \ (\le 4.0)$	V
Operating Temperature	TA	-40	+85	°C
Storage Temperature	Тѕтс	-40	+125	°C

^{* :} All voltages are referenced to VSS = 0 V.

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS

Parameter	Cymbal		llmit		
Parameter	Symbol	Min	Тур	Max	Unit
Power Supply Voltage*	Vcc	3.0	3.3	3.6	V
High Level Input Voltage*	VIH	Vcc × 0.8	_	Vcc + 0.5 (≤ 4.0)	V
Low Level Input Voltage*	VıL	-0.5	_	+0.6	V
Operating Temperature	TA	- 40	_	+85	۰C

^{*:} All voltages are referenced to VSS = 0 V.

WARNING:

The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure. No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

■ ELECTRICAL CHARACTERISTICS

1. DC Characteristics

(within recommended operating conditions)

Parameter	Symbol	Condition			Unit	
Parameter	Syllibol	Condition	Min	Тур	Max	Ollit
Input Leakage Current	Iu	V _{IN} = 0 V to V _{CC}	_	_	10	μΑ
Output Leakage Current	ILO	$V_{\text{OUT}} = 0 \text{ V to } V_{\text{CC}},$ $\overline{\text{CE}}1 = \text{V}_{\text{IH}} \text{ or } \overline{\text{OE}} = \text{V}_{\text{IH}}$	_	_	10	μΑ
Operating Power Supply Current	Icc	CE1 = 0.2 V, CE2 = Vcc - 0.2 V, lout = 0 mA*1	_	10	15	mA
	136	<u>CE</u> 1 ≥ Vcc – 0.2 V		10	50	μА
Standby Current		CE2 ≤ 0.2 V*2				
		$\overline{OE} \ge V_{CC} - 0.2 \text{ V}, \overline{WE} \ge V_{CC} - 0.2 \text{ V}^{*2}$	_			
		$\overline{LB} \ge V_{CC} - 0.2 \text{ V}, \overline{UB} \ge V_{CC} - 0.2 \text{ V}^{*2}$				
High Level Output Voltage	Vон	Iон = − 1.0 mA	$Vcc \times 0.8$	_	_	V
Low Level Output Voltage	Vol	IoL = 2.0 mA	_	_	0.4	٧

^{*1 :} During the measurement of Icc , the Address, Data In were taken to only change once per active cycle. lout : output current

^{*2 :} All pins other than setting pins should be input at the CMOS level voltages such as H \geq Vcc - 0.2 V, L \leq 0.2 V.

2. AC Characteristics

• AC Test Conditions

Supply Voltage : 3.0 V to 3.6 VOperating Temperature $: -40 \text{ }^{\circ}\text{C to } +85 \text{ }^{\circ}\text{C}$ Input Voltage Amplitude : 0.3 V to 2.7 V

Input Rising Time : 5 ns Input Falling Time : 5 ns

Input Evaluation Level : 2.0 V / 0.8 V
Output Evaluation Level : 2.0 V / 0.8 V
Output Impedance : 50 pF

(1) Read Cycle

(within recommended operating conditions)

Dovometer	Cymbal	Va	lue	Unit
Parameter	Symbol	Min	Max	Unit
Read Cycle time	t RC	150		ns
CE1 Active Time	t _{CA1}	120		ns
CE2 Active Time	t _{CA2}	120		ns
OE Active Time	t _{RP}	120		ns
LB, UB Active Time	t BP	120		ns
Precharge Time	t PC	20		ns
Address Setup Time	t as	0		ns
Address Hold Time	tан	50		ns
OE Setup Time	t es	0		ns
LB, UB Setup Time	t BS	5		ns
Output Data Hold time	tон	0		ns
Output Set Time	t LZ	30		ns
CE1 Access Time	t _{CE1}	_	100	ns
CE2 Access Time	t _{CE2}	_	100	ns
OE Access Time	t oe	_	100	ns
Output Floating Time	tонz	_	20	ns

(2) Write Cycle

(within recommended operating conditions)

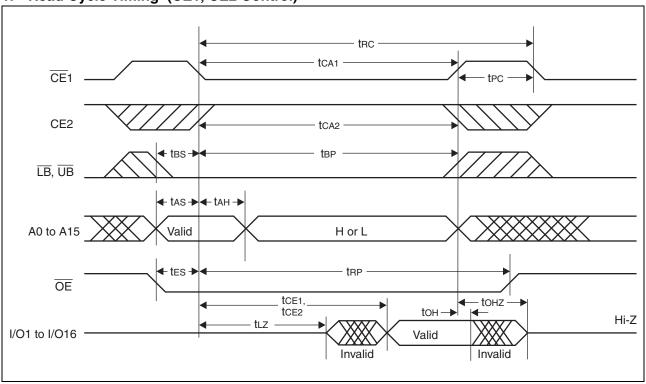
		Va		
Parameter	Symbol	Va	Unit	
i didilicioi	Cymbol	Min	Max	O i iii
Write Cycle Time	twc	150	_	ns
CE1 Active Time	t _{CA1}	120		ns
CE2 Active Time	t _{CA2}	120		ns
LB, UB Active Time	tвР	120		ns
Precharge Time	tpc	20	_	ns
Address Setup Time	tas	0	_	ns
Address Hold Time	tан	50		ns
LB, UB Setup Time	t _{BS}	5	_	ns
Write Pulse Width	twp	120	_	ns
Data Setup Time	tos	0	_	ns
Data Hold Time	tон	50	_	ns
Write Setup Time	tws	0	_	ns

3. Pin Capacitance

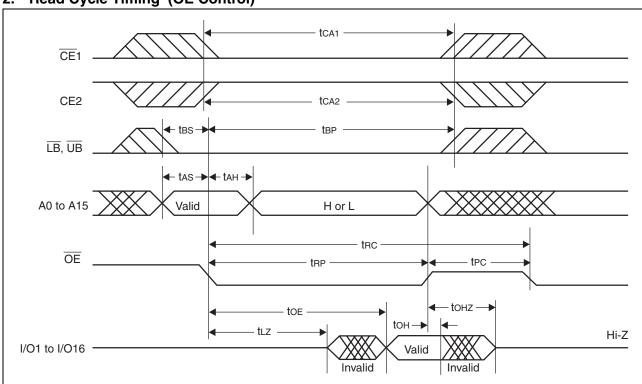
Parameter	Symbol Condition			Unit		
Faranielei	Зуппоп	Condition	Min	Тур	Max	Oilit
Input Capacitance	Cin	$V_{IN} = V_{OUT} = 0 V,$	_	_	10	pF
Output Capacitance	Соит	f = 1 MHz, T _A = + 25 °C	_	_	10	pF

■ TIMING DIAGRAMS

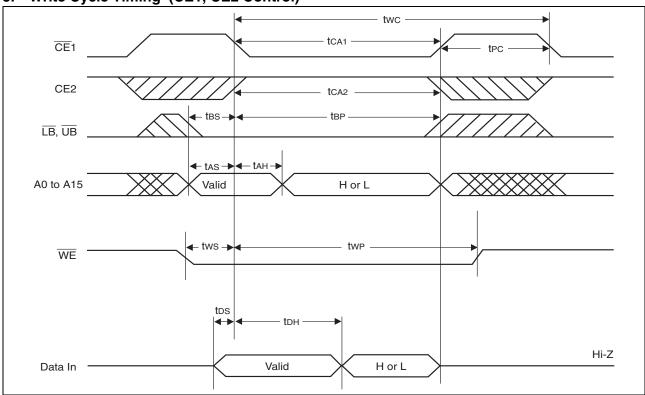
1. Read Cycle Timing (CE1, CE2 Control)



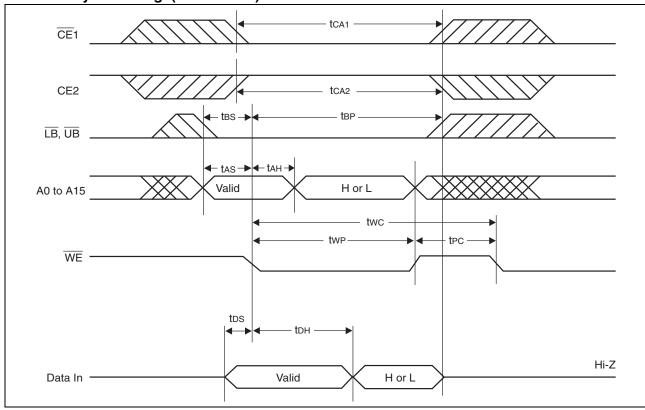
2. Read Cycle Timing (OE Control)



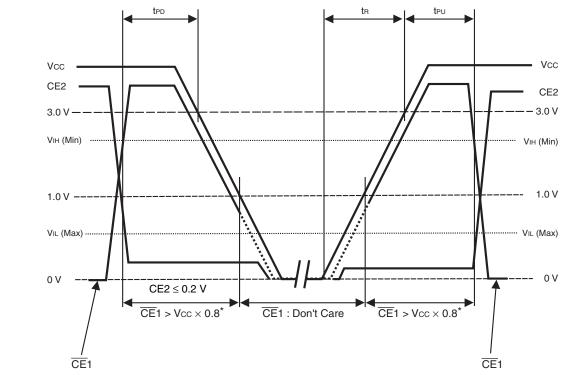
3. Write Cycle Timing (CE1, CE2 Control)



4. Write Cycle Timing (WE Control)



■ POWER ON/OFF SEQUENCE



*: CE1 (Max) < Vcc + 0.5 V

Notes: • Use either of CE1 or CE2, or both for disable control of the device.

- Because turning the power on from an intermediate level may cause malfunctions, when the power is turned on, Vcc is required to be started from 0 V.
- If the device does not operate within the specified conditions of read cycle, write cycle, power on/off sequence, memory data can not be guaranteed.
- When turning the power on or off, it is recommended that CE2 is connected to ground to prevent unexpected writing.

(within recommended operating conditions)

Parameter	Symbol		Unit		
Farameter	Зуппоп	Min	Тур	Max	Oilit
CE1 LEVEL hold time for Power OFF	t PD	85	_	_	ns
CE1 LEVEL hold time for Power ON	t PU	85	_	_	ns
Power supply rising time	t _R	0.05	_	200	ms

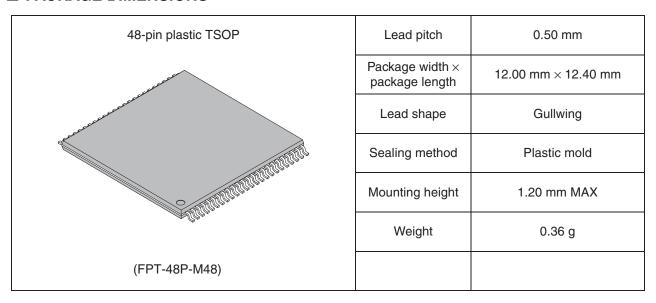
■ NOTES ON USE

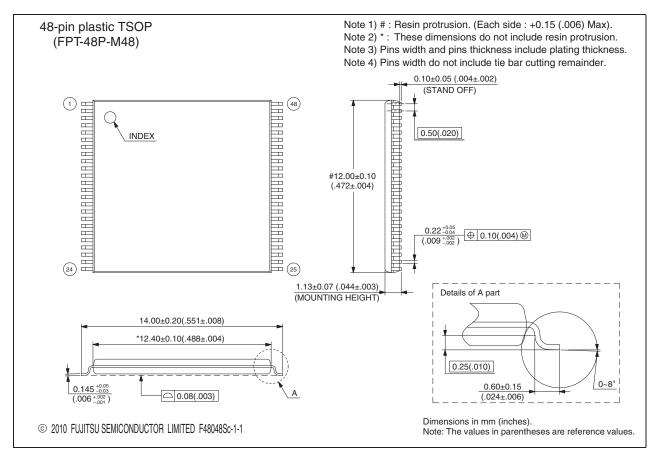
After the IR reflow completed, it is not guaranteed to hold the data written prior to the IR reflow.

■ ORDERING INFOMATION

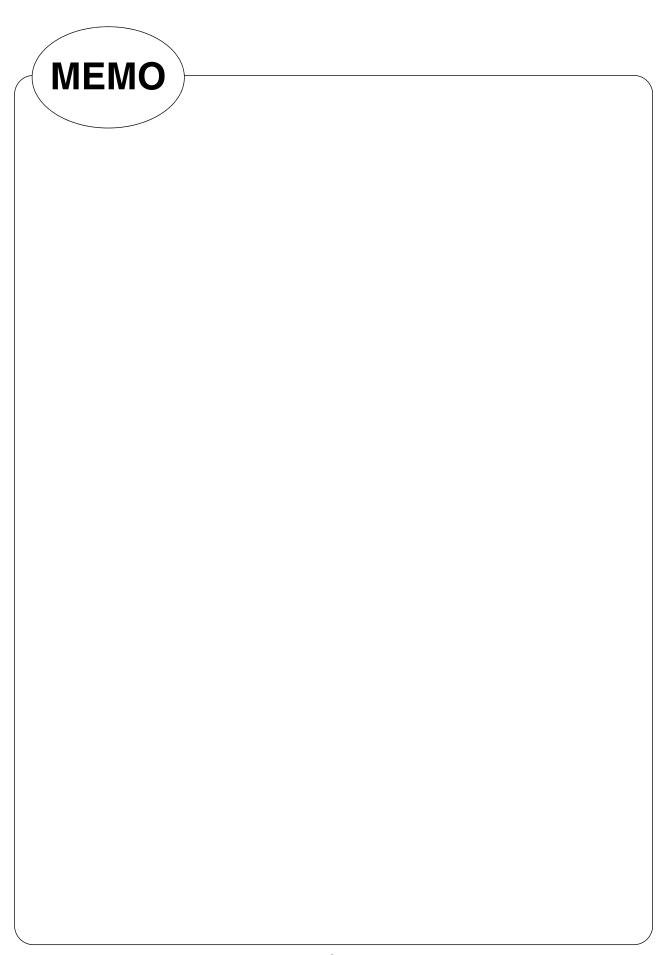
Part number	Package
MB85R1002ANC-GE1	48-pin plastic TSOP(1) (FPT-48P-M48)

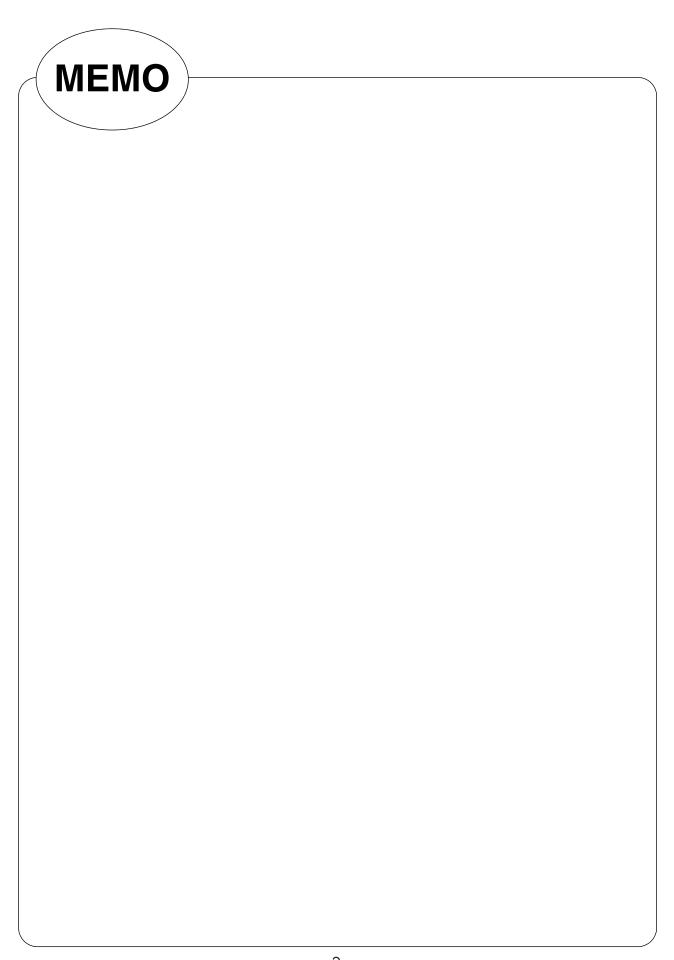
■ PACKAGE DIMENSIONS





Please check the latest package dimension at the following URL. http://edevice.fujitsu.com/package/en-search/





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